

Notice of References Cited

Application/Control No.

10/726,745

Applicant(s)/Patent Under
Reexamination
SURNILLA ET AL.

Examiner

Tu M. Nguyen

Art Unit

3748

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,462,039	10-1995	Mamiya et al.	123/686
	B	US-			
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	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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